











CSD18533Q5A

SLPS388B - SEPTEMBER 2012 - REVISED JANUARY 2015

# CSD18533Q5A 60 V N-Channel NexFET™ Power MOSFET

### **Features**

- Ultra Low Qg and Qgd
- Low Thermal Resistance
- Avalanche Rated
- Logic Level
- Pb Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5 mm x 6 mm Plastic Package

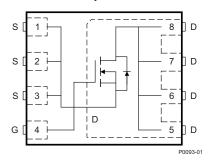
## **Applications**

- DC-DC Conversion
- Secondary Side Synchronous Rectifier
- Motor Control

### 3 Description

This 4.7 m $\Omega$ , 60 V, SON 5 × 6 mm NexFET<sup>TM</sup> power MOSFET is designed to minimize losses in power conversion applications.





#### R<sub>DS(on)</sub> vs V<sub>GS</sub> 16 T<sub>C</sub> = 25°C | Id = 18A $R_{DS(on)}$ - On-State Resistance (m $\Omega$ ) 14 T<sub>C</sub> = 125°C ld = 18A 12 10 8 6 4 2 0 0 2 4 8 10 12 V<sub>GS</sub> - Gate-to- Source Voltage (V) G001

#### **Product Summary**

$T_A = 25^\circ$	С	TYPICAL VA	UNIT	
$V_{DS}$	Drain-to-Source Voltage	60		٧
$Q_g$	Gate Charge Total (10 V)	29		nC
$Q_{gd}$	Gate Charge Gate-to-Drain	5.4	nC	
R <sub>DS(on)</sub>	Drain-to-Source On-Resistance	$V_{GS} = 4.5 \text{ V}$ 6.5		mΩ
	Diam-to-Source On-Resistance	V <sub>GS</sub> = 10 V 4.7		mΩ
$V_{GS(th)}$	Threshold Voltage	1.9	V	

## Ordering Information<sup>(1)</sup>

Device	Qty Media		Package	Ship
CSD18533Q5A	2500	13-Inch Reel	SON 5 mm × 6 mm	Tape and
CSD18533Q5AT	250	7-Inch Reel	Plastic Package	Reel

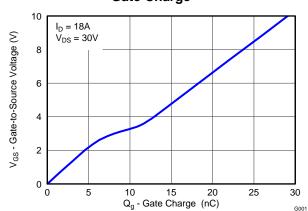
For all available packages, see the orderable addendum at the end of the data sheet.

### **Absolute Maximum Ratings**

T <sub>A</sub> = 2	5°C	VALUE	UNIT
$V_{DS}$	Drain-to-Source Voltage	60	V
$V_{GS}$	Gate-to-Source Voltage	±20	V
	Continuous Drain Current (Package limited), T <sub>C</sub> = 25°C	100	
I <sub>D</sub>	Continuous Drain Current (Silicon limited), $T_C = 25$ °C	103	Α
	Continuous Drain Current, T <sub>A</sub> = 25°C <sup>(1)</sup>	17	
$I_{DM}$	Pulsed Drain Current, T <sub>A</sub> = 25°C <sup>(2)</sup>	267	Α
П	Power Dissipation <sup>(1)</sup>	3.2	W
$P_D$	Power Dissipation, TC = 25°C	116	VV
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	-55 to 150	°C
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D$ = 53 A, L = 0.1 mH, $R_G$ = 25 $\Omega$	140	mJ

- (1) Typical  $R_{\theta JA} = 40^{\circ} \text{C/W}$  on a 1 inch<sup>2</sup>, 2 oz. Cu pad on a 0.06 inch thick FR4 PCB.
- (2) Max  $R_{\theta JC} = 1.3^{\circ}C/W$ , pulse duration  $\leq 100 \mu s$ , duty cycle  $\leq$ 1%

#### **Gate Charge**





## **Table of Contents**

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## **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (May 2013) to Revision B	Pag
Added part number to title	
Increased Pulsed Drain Current to 267 A	
Added line for max power dissipation with case temperature held to 25° C	
Updated pulsed current conditions	
Changed Figure 1 to normalized R <sub>eJC</sub> curve	
Updated SOA in Figure 10	
Changes from Original (September 2012) to Revision A	Pag

		_
•	Changed the R <sub>eJC</sub> MAX value From: 2.3°C/W to 1.3°C/W	3
•	Changed From: Max R <sub>θJA</sub> = 121°C/W To: Max R <sub>θJA</sub> = 125°C/W	4
•	Changed Typ Rth <sub>JA</sub> = 99°C/W To:Rth <sub>JA</sub> = 100°C/W in Figure 1	4
•	Added the Recommended Stencil Opening section	9

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## 5 Specifications

### 5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
"STATIC	CHARACTERISTICS		•			
$BV_{DSS}$	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	$V_{GS} = 0 \text{ V}, V_{DS} = 48 \text{ V}$			1	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{DS} = 0 \text{ V}, V_{GS} = 20 \text{ V}$			100	nA
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1.5	1.9	2.3	V
D	Drain-to-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$		6.5	8.5	mΩ
R <sub>DS(on)</sub>	Dialii-to-Source Ori-Resistance	$V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$		4.7	5.9	$m\Omega$
$g_{fs}$	Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 18 \text{ A}$		122		S
DYNAMIC	C CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance			2200	2750	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$		292	365	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			7	9	рF
$R_{G}$	Series Gate Resistance			1.3	2.6	Ω
$Q_g$	Gate Charge Total (4.5 V)			14	18	nC
$Q_g$	Gate Charge Total (10 V)			29	36	nc
$Q_{gd}$	Gate Charge Gate-to-Drain	$V_{DS} = 30 \text{ V}, I_{D} = 18 \text{ A}$		5.4		nC
$Q_{gs}$	Gate Charge Gate-to-Source			6.6		nC
Q <sub>g(th)</sub>	Gate Charge at Vth			4.7		nC
Q <sub>oss</sub>	Output Charge	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$		31		nC
t <sub>d(on)</sub>	Turn On Delay Time			5.2		ns
t <sub>r</sub>	Rise Time	V 20 V V 40 V L 48 A B 0.0		5.5		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_{DS} = 18 \text{ A}, R_G = 0 \Omega$		15		ns
$t_f$	Fall Time			2.0		ns
DIODE C	HARACTERISTICS	·				
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 18 A, V <sub>GS</sub> = 0 V		8.0	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V = 20 V I = 19 A di/dt = 200 A/ug		68		nC
t <sub>rr</sub>	Reverse Recovery Time	$V_{DS}$ = 30 V, $I_F$ = 18 A, di/dt = 300 A/ $\mu$ s		40		ns

### 5.2 Thermal Information

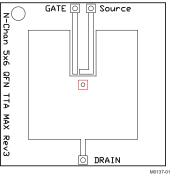
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal Resistance Junction to Case <sup>(1)</sup>			1.3	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (1)(2)			50	C/VV

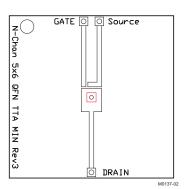
 $R_{\theta JC}$  is determined with the device mounted on a 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu pad on a 1.5 inch × 1.5 inch (3.81 cm × 3.81 cm), 0.06 inch (1.52 mm) thick FR4 PCB.  $R_{\theta JC}$  is specified by design, whereas  $R_{\theta JA}$  is determined by the user's board design. Device mounted on FR4 material with 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu.

Product Folder Links: CSD18533Q5A





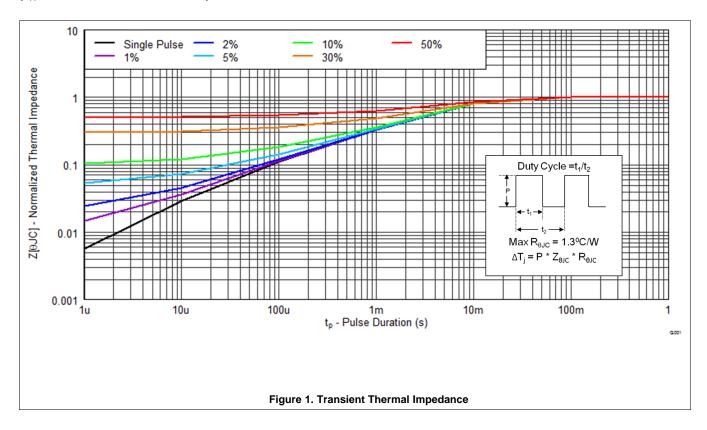
Max  $R_{\theta JA} = 50^{\circ} C/W$  when mounted on 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>) of 2 oz. (0.071 mm thick) Cu.



Max  $R_{\theta JA} = 125^{\circ} C/W$  when mounted on a minimum pad area of 2 oz. (0.071 mm thick) Cu.

## 5.3 Typical MOSFET Characteristics

(T<sub>A</sub> = 25°C unless otherwise stated)

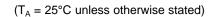


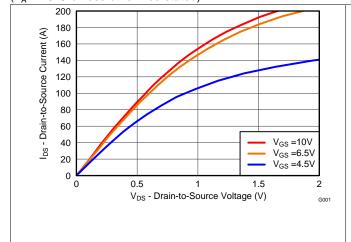
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### **Typical MOSFET Characteristics (continued)**





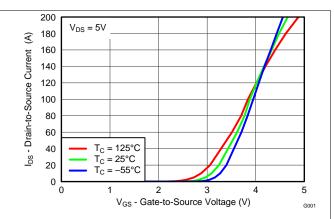


Figure 2. Saturation Characteristics

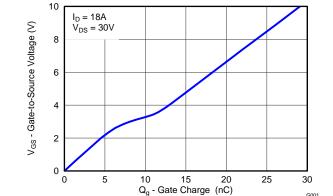


Figure 3. Transfer Characteristics

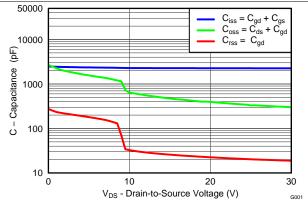


Figure 4. Gate Charge

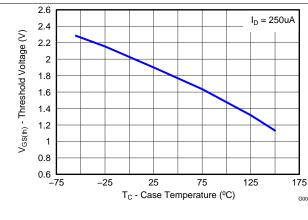


Figure 5. Capacitance

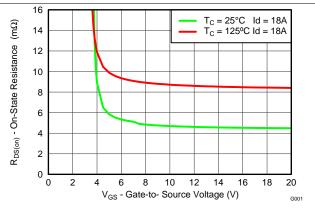


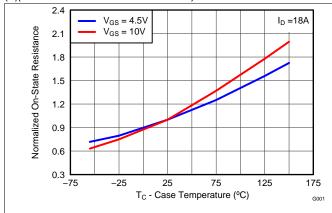
Figure 6. Threshold Voltage vs Temperature

Figure 7. On-State Resistance vs Gate-to-Source Voltage



## **Typical MOSFET Characteristics (continued)**

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 



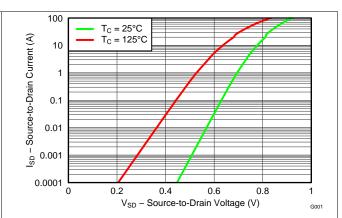


Figure 8. Normalized On-State Resistance vs Temperature

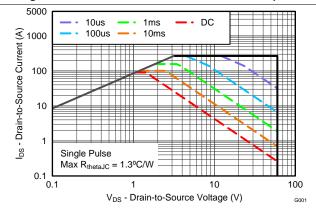


Figure 9. Typical Diode Forward Voltage

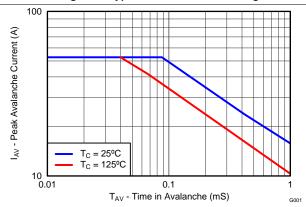


Figure 10. Maximum Safe Operating Area



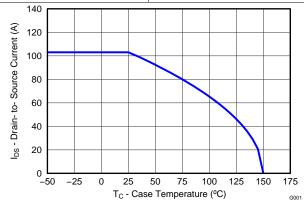


Figure 12. Maximum Drain Current vs Temperature



# 6 Device and Documentation Support

### 6.1 Trademarks

NexFET is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 6.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

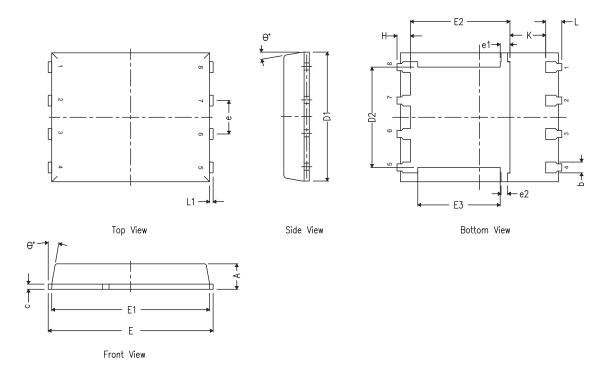
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# 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

### 7.1 Q5A Package Dimensions

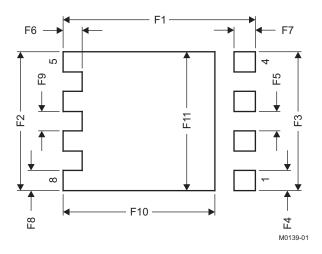


DIM		MILLIMETERS	
DIIVI	MIN	NOM	MAX
Α	0.90	1.00	1.10
b	0.33	0.41	0.51
С	0.20	0.25	0.34
D1	4.80	4.90	5.00
D2	3.61	3.81	4.02
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
E3	3.03	3.13	3.23
е	1.17	1.27	1.37
e1	0.27	0.37	0.47
e2	0.15	0.25	0.35
Н	0.41	0.56	0.71
K	1.10		
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
θ	0°		12°

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### 7.2 Recommended PCB Pattern

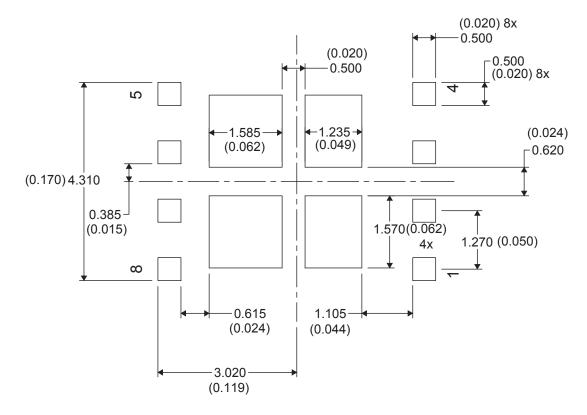


### **Recommended PCB Pattern (continued)**

DIM	MILLIM	ETERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
F1	6.205	6.305	0.244	0.248		
F2	4.46	4.56	0.176	0.18		
F3	4.46	4.56	0.176	0.18		
F4	0.65	0.7	0.026	0.028		
F5	0.62	0.67	0.024	0.026		
F6	0.63	0.68	0.025	0.027		
F7	7 0.7 0.8		0.028	0.031		
F8	0.65	0.7	0.026	0.028		
F9	0.62	0.67	0.024	0.026		
F10	10 4.9 5		0.193	0.197		
F11	4.46	4.56	0.176	0.18		

For recommended circuit layout for PCB designs, see application note SLPA005 - Reducing Ringing Through PCB Layout Techniques.

## 7.3 Recommended Stencil Opening

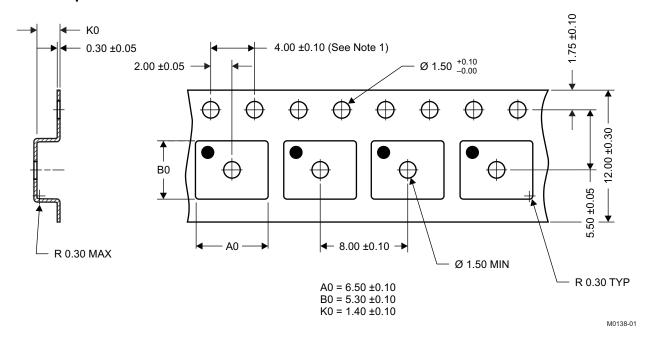


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### 7.4 Q5A Tape and Reel Information



### Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1mm in 100mm, noncumulative over 250mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3mm above the bottom of the pocket

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## PACKAGE OPTION ADDENDUM

29-Jun-2018

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CSD18533Q5A	ACTIVE	VSONP	DQJ	8	2500	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD18533	Samples
CSD18533Q5AT	ACTIVE	VSONP	DQJ	8	250	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD18533	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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